

Notice of References Cited	Application/Control No. 10/626,011	Applicant(s)/Patent Under Reexamination DE WAAL, ABRAHAM B.	
	Examiner TuyetLien (Lien) T. Tran	Art Unit 2179	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,923,307	07-1999	Hogle, IV, Francis M.	345/4
*	C	US-6,832,355	12-2004	Duperrouzel et al.	715/788
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as-applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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